

Notice of References Cited

Application/Control No.

10/577,453

Applicant(s)/Patent Under
Reexamination
VAINIO ET AL.

Examiner

MARCOS BATISTA

Art Unit

2617

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0186845 A1	12-2002	Dutta et al.	380/247
*	B	US-2003/0195010 A1	10-2003	Pattabiraman et al.	455/517
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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